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N-Channel SuperFET[®] II MOSFET

800 V, 2.2 A, 4.3 Ω

Features

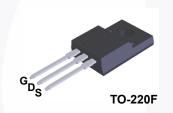
- R_{DS(on)} = 3.4 Ω (Typ.)
- Ultra Low Gate Charge (Typ. Q_g = 6.8 nC)
- Low E_{oss} (Typ. 0.8 uJ @ 400V)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 36 pF)
- 100% Avalanche Tested
- RoHS Compliant
- · ESD Improved Capability

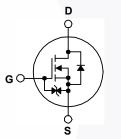
Applications

- AC DC Power Supply
- LED Lighting

Description

SuperFET[®] II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as Audio, Laptop adapter, Lighting, ATX power and industrial power applications.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		FCPF4300N80Z	Unit				
V _{DSS}	Drain to Source Voltage		800	V			
V _{GSS}	Cata ta Sauraa Maltaga	- DC	. 7	±20	- V		
	Gate to Source Voltage	- AC (f >	1 Hz)	±30			
1	Drain Current	- Continuous (T _C = 25 ^o C)		2.2*	A		
I _D		- Continuous (T _C = 100 ^o C)		1.4*	A		
I _{DM}	Drain Current	- Pulsed (I	(Note 1)		Α		
E _{AS}	Single Pulsed Avalanche Energy (Note 2)			8.2	mJ		
I _{AR}	Avalanche Current (Note 1)			0.32	Α		
E _{AR}	Repetitive Avalanche Energy (Note 1)			0.19	mJ		
dv/dt	MOSFET dv/dt		100	V/ns			
	Peak Diode Recovery dv/dt	Note 3)	20				
P _D	Bower Dissipation	(T _C = 25°C)		19.2	W		
	Power Dissipation	- Derate Above 25°C		0.15	W/ºC		
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C		
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C		
Drain current limited	d by maximum junction temperature, with h	eatsink.			·		

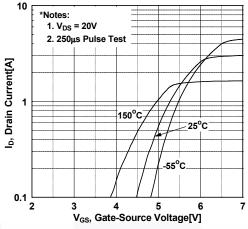
Thermal Characteristics

Symbol	Parameter	FCPF4300N80Z	Unit		
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	6.5	°C/W		
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	62.5	0/10		

Part NumberTop MarkFCPF4300N80ZFCPF4300N80Z		Top Mark	Pac	ckage Packing Method Reel Siz		ize	Tape Wid	ith C	Quantity	
		TO-2	O-220F Tube N/A			N/A		50 units		
Electrica	l Chara	icteristics T _C = 25	5 ^o C unle	ess oth	erwise noted.					
Symbol		Parameter		Test Conditions			Min.	Тур.	Max.	Unit
Off Chara	cteristics									
BV _{DSS}	Drain to Source Breakdown Voltage		aae	V _{GS} = 0 V, I _D = 1 mA, T _J = 25°C			800	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdov	Breakdown Voltage Temperature Coefficient		$I_D = 1 \text{ mA}, \text{ Referenced to } 25^{\circ}\text{C}$			-	0.85	-	V/ºC
	Zero Gate Voltage Drain Current			V_{DS} = 800 V, V_{GS} = 0 V V_{DS} = 640 V, V_{GS} = 0 V, T_C = 125°C			-	-	25	
IDSS							-	-	250	μA
I _{GSS}	Gate to B	Gate to Body Leakage Current			±20 V, V _{DS} = 0 V		-	-	±10	μA
On Charao	cteristics									
V _{GS(th)}	Gate Thre	eshold Voltage		V _{GS} =	V _{DS} , I _D = 0.16 mA		2.5	-	4.5	V
R _{DS(on)}	Static Dra	ain to Source On Resista	ance	V _{GS} =	10 V, I _D = 0.8 A		-	3.4	4.3	Ω
9 _{FS}	Forward [•]	Transconductance		V_{DS} =	20 V, I _D = 0.8 A		-	0.52	-	S
Dynamic (Character	ristics								
C _{iss} Input Capacitance						267	355	pF		
C _{oss}		apacitance		V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz			12	16	pF	
C _{rss}	-	Transfer Capacitance				-	0.78	-	pF	
C _{oss}		out Capacitance		V _{DS} = 480 V, V _{GS} = 0 V, f = 1 MHz			-	6.2	-	pF
C _{oss(eff.)}	Effective	ffective Output Capacitance		$V_{DS} = 0 V \text{ to } 480 V, V_{GS} = 0 V$			-	36	-	pF
Q _{g(tot)}	Total Gate	e Charge at 10V			640 V, I _D = 1.6 A,		-	6.8	8.8	nC
Q _{gs}	Gate to S	ource Gate Charge		$V_{GS} = 10 V$		-	1.38	-	nC	
Q _{gd}	Gate to D	rain "Miller" Charge				(Note 4)	-	3.0	-	nC
ESR	Equivaler	nt Series Resistance		f = 1 N	1Hz		-	2.9	-	Ω
Switching	Charact	eristics								
t _{d(on)}		Delay Time					-	10	30	ns
t _r		Rise Time		V _{DD} =	400 V, I _D = 1.6 A,	-	-	6.5	23	ns
t _{d(off)}		Delay Time		$V_{GS} = 10 \text{ V}, \text{ R}_{g} = 4.7 \Omega$ (Note 4)			21	52	ns	
t _f	Turn-Off	,					16	42	ns	
	ree Died	e Characteristics				, ,	/			
I _S		Continuous Drain to So	ource D)iode Fr				-	2.2	A
I _{SM}		Pulsed Drain to Source					-	-	3.2	A
V _{SD}		Source Diode Forward V			= 0 V, I _{SD} = 1.6 A		-	-	1.2	V
t _{rr}		Recovery Time	onago	$V_{GS} = 0 V, I_{SD} = 1.6 A,$ $V_{IF}/dt = 100 A/\mu s$		-	209	-	ns	
Q _{rr}		Recovery Charge				-	1.2	-	μC	
lotes:		,			·					
	g: pulse width lir	mited by maximum junction tem	perature.							
2. I _{AS} = 0.32 A, R										

Typical Performance Characteristics Figure 1. On-Region Characteristics V_{GS} = 10.0V 8.0V 7.0V 6.5V 6.0V l_b, Drain Current[A] 5.5V 5.0V Notes: 1. 250µs Pulse Test 2. $T_{C} = 25^{\circ}C$ 0.1 ∟ 0.3 1 10 20 V_{DS}, Drain-Source Voltage[V] Figure 3. On-Resistance Variation vs. **Drain Current and Gate Voltage** 8 *Note: T_C = 25°C Drain-Source On-Resistance R_{DS(ON)} [Ω], $V_{GS} = 10V$ V_{GS} = 20V 2 0 1 2 3 4 I_D, Drain Current [A] **Figure 5. Capacitance Characteristics** 10000 1000 Ciss Capacitances [pF] 100 Coss 10 *Note: 1. V_{GS} = 0V 2. f = 1MHz Crss 1 Ciss = Cgs + Cgd (Cds = shorted) Coss = Cds + Cgd Crss = Cgd 0.1 └─ 0.1 1000 10 100 1 V_{DS}, Drain-Source Voltage [V] ©2014 Fairchild Semiconductor Corporation 3 FCPF4300N80Z Rev. 1.1

Figure 2. Transfer Characteristics





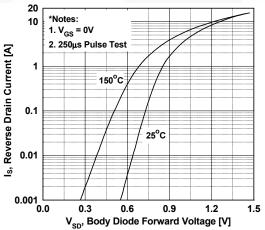
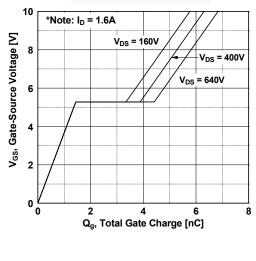
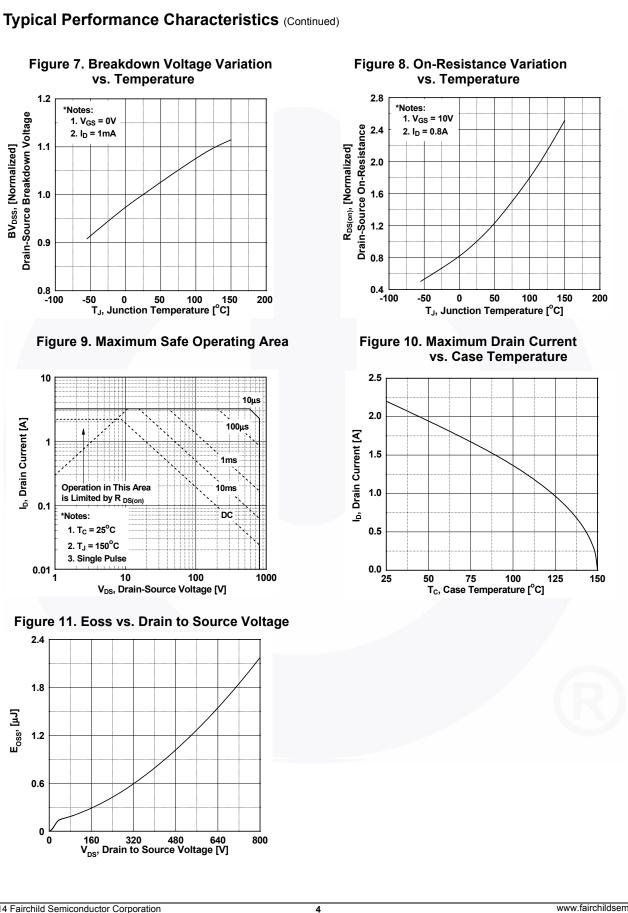


Figure 6. Gate Charge Characteristics

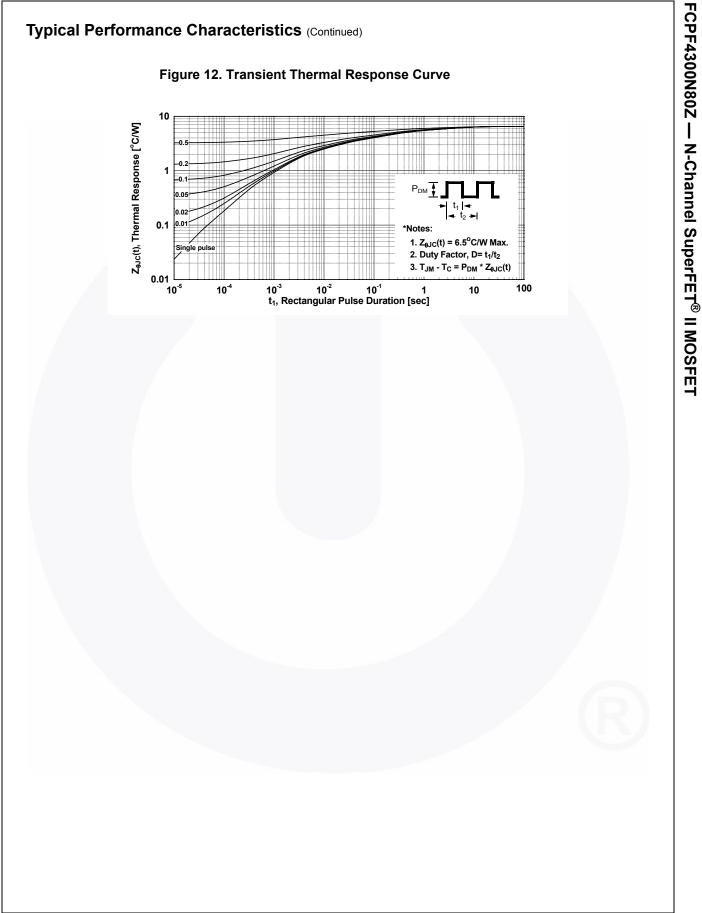


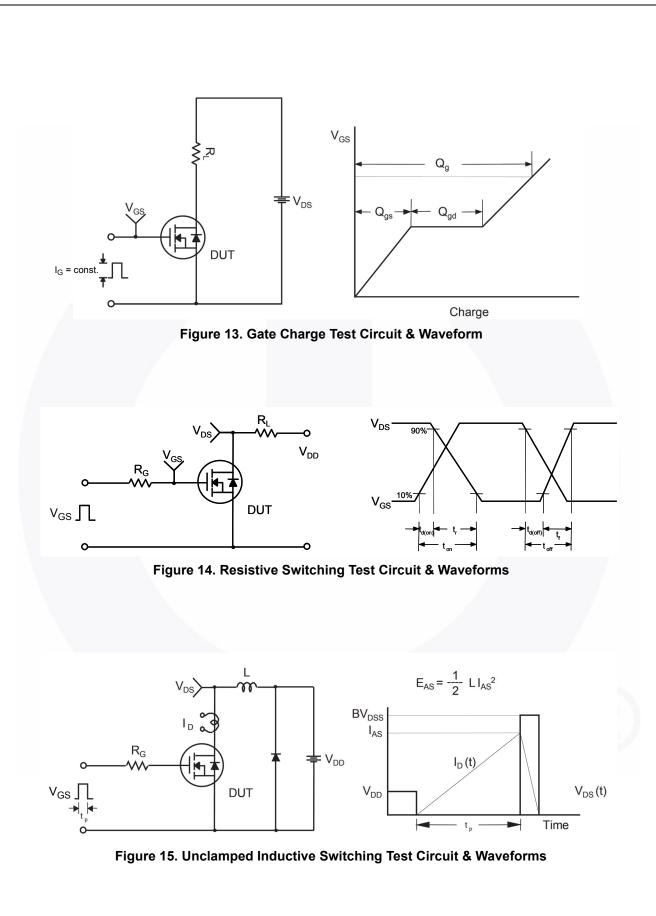


E_{oss}, [μJ]

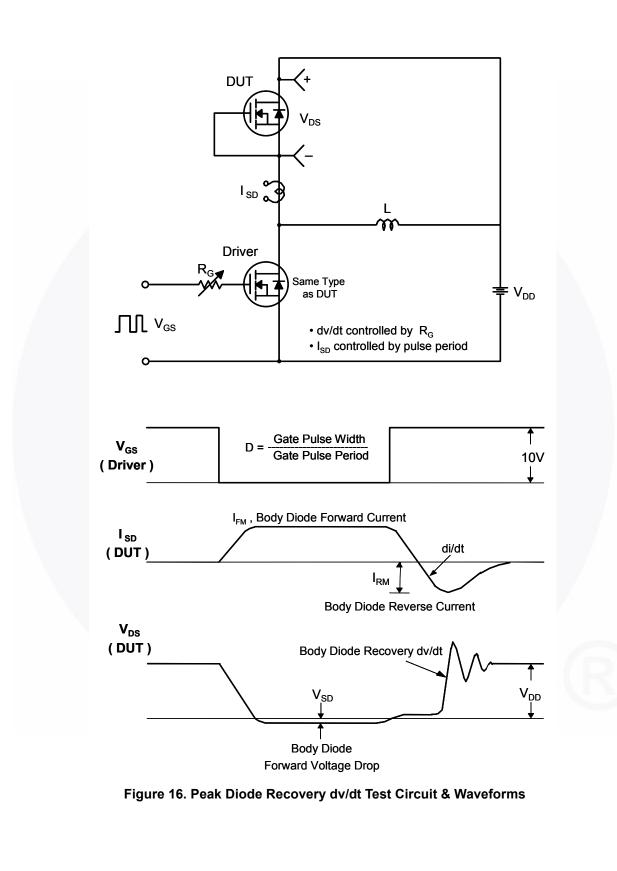
BV_{DSS}, [Normalized]

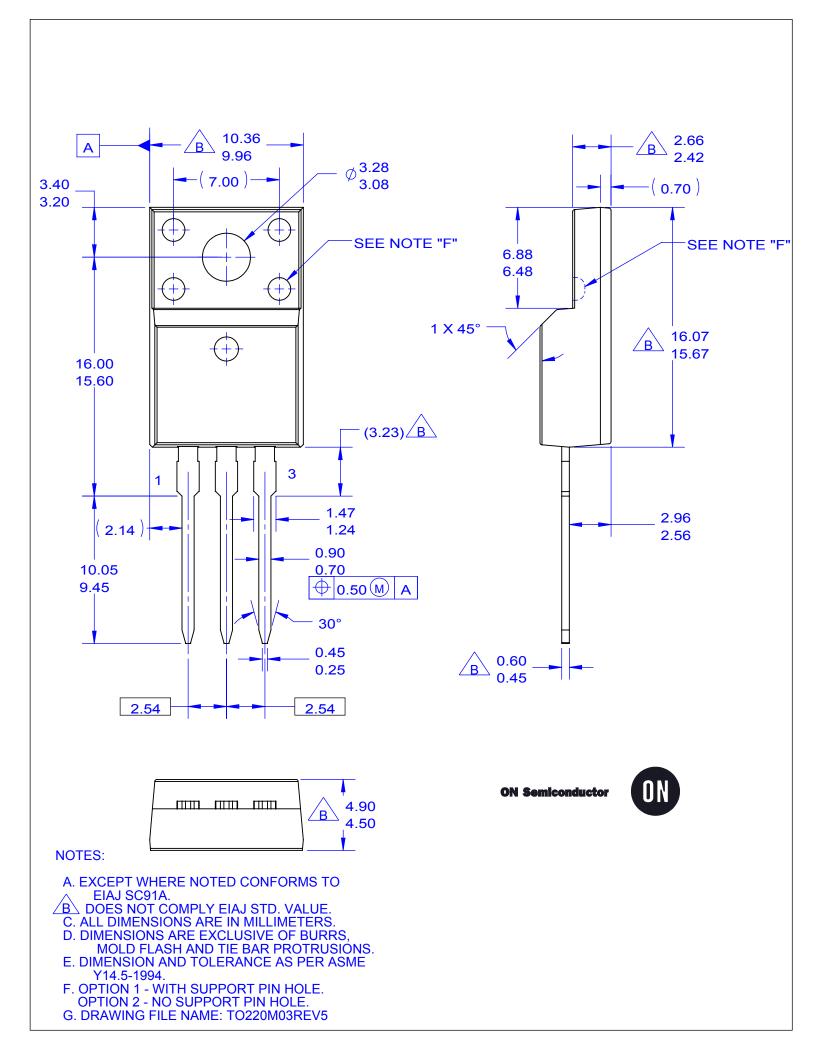
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